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				Application Number	10/644,801-Conf. #7386
				Filing Date	August 21, 2003
				First Named Inventor	Akira Shoji
				Art Unit	2819
				Examiner Name	J. B. Jeanglaude
Sheet	1	of	1	Attorney Docket Number	AIS-0008

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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FOREIGN PATENT DOCUMENTS						
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JBJ	CA	Yamamori et al., "NbN/TiN _x /NbN/TiN _x /NbN double-barrier junction arrays for programmable voltage standards," Applied Physics Letters, Vol. 80, No. 8, Pages 1415-1417, American Institute of Physics (February 25, 2002)	
JBJ	CB	Kohjiro et al., "Surface Resistance of Epitaxial and Polycrystalline NbCN Films in Submillimeter Wave Region," IEEE Transactions on Applied Superconductivity, Vol. 3, No. 1, Pages 1765-1767, IEEE (March 1993)	

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Examiner Signature	<i>Jean Bruner Jeanglaude</i>	Date Considered	12/02/04
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